Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/757,901	OIKAWA ET AL.	
Examiner	Art Unit	
Alain L. Bashore	1762	

	SEARCHED				
Class	Subclass	Date	Examiner		
427	127, 128, 130, 121 132	9/18/2005	АВ		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (attached)	9/18/2005	AB
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